



# PERRY JOHNSON LABORATORY ACCREDITATION, INC.

## Certificate of Accreditation

*Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:*

### ***Elcometer Inc.***

***1893 Rochester Industrial Drive, Rochester Hills, MI 48309***

*(Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:*

### **ISO/IEC 17025:2017**

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated April 2017):

***Dimensional, Chemical, Electrical, Mechanical, Time & Frequency Calibration***  
*(As detailed in the supplement)*

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

Tracy Szerszen  
President/Operations Manager

Perry Johnson Laboratory  
Accreditation, Inc. (PJLA)  
755 W. Big Beaver, Suite 1325  
Troy, Michigan 48084

*Initial Accreditation Date:*

July 26, 2018

*Issue Date:*

July 26, 2018

*Expiration Date:*

September 30, 2020

*Accreditation No.:*

99996

*Certificate No.:*

L18-362

*The validity of this certificate is maintained through ongoing assessments based on a continuous accreditation cycle. The validity of this certificate should be confirmed through the PJLA website: [www.pjilabs.com](http://www.pjilabs.com)*



# Certificate of Accreditation: Supplement

## Elcometer Inc.

1893 Rochester Industrial Drive, Rochester Hills, MI 48309  
 Contact Name: Joseph Walker Phone: 248-650-0500

Accreditation is granted to the facility to perform the following calibrations:

### Dimensional

| MEASURED INSTRUMENT, QUANTITY OR GAUGE   | RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE | CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY ( $\pm$ ) | CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED |
|--|---|--|--|
| Profilometers <sup>F</sup>               | Up to 508 $\mu$ m                           | 1 $\mu$ m to 500 $\mu$ m   | Foils/Shims  |
| Ultrasonic Thickness Gauges <sup>F</sup> | 0.1 in to 1 in                              | 0.000 1 in to 0.5 in   | Step Blocks  |
|  |   | 0.001 in to 0.1 in   |  |
| Coating Thickness <sup>F</sup>           | 6 $\mu$ m to 1 935 $\mu$ m                  | 5 % of true thickness  | NIST Tiles   |
|  | 6 $\mu$ m to 1 500 $\mu$ m                  | 1 $\mu$ m  | DFT Standards                                      |
|  | 1 500 $\mu$ m to 4 000 $\mu$ m              | 2 $\mu$ m  |  |
|  | 4 000 $\mu$ m to 25 400 $\mu$ m             | 4 $\mu$ m  |  |
| Thickness <sup>F</sup>                   | 15 mm to 50.5 mm                            | 0.5 mm   | Rebar Test Blocks                                  |

### Chemical

| MEASURED INSTRUMENT, QUANTITY OR GAUGE | RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE                 | CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY ( $\pm$ ) | CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED |
|--|---|--|--|
| Conductivity <sup>F</sup>              | 0.5 $\mu$ g/cm <sup>2</sup> to 47.4 $\mu$ g/cm <sup>2</sup> | 0.15 % of Reading  | Conductivity Tiles                                 |

### Electrical

| MEASURED INSTRUMENT, QUANTITY OR GAUGE | RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE | CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY ( $\pm$ ) | CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED |
|--|---|--|--|
| DC Voltage <sup>F</sup>                | 300 V to 1 000 V                            | 0.025 % of Reading   | Digital Multimeter                                 |
|  | 3 V to 25 000 V                             | 1 % of Reading   | High Voltage Probe                                 |

### Mechanical

| MEASURED INSTRUMENT, QUANTITY OR GAUGE | RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE | CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY ( $\pm$ ) | CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED |
|--|---|--|--|
| Gloss <sup>F</sup>                     | 88 gu to 100 gu                             | 0.5 gu   | Gloss Tiles  |
|  | 15 gu to 100 gu                             | 0.5 gu   |  |

### Time & Frequency

| MEASURED INSTRUMENT, QUANTITY OR GAUGE | RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE | CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY ( $\pm$ ) | CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED |
|--|---|--|--|
| Time <sup>F</sup>                      | 0.5 min to 86.4 min                         | 0.037 sec  | Digital Control Company Stopwatch                  |



## Certificate of Accreditation: Supplement

### Elcometer Inc.

1893 Rochester Industrial Drive, Rochester Hills, MI 48309  
Contact Name: Joseph Walker Phone: 248-650-0500

*Accreditation is granted to the facility to perform the following calibrations:*

1. The CMC (Calibration and Measurement Capability) stated for calibrations included on this scope of accreditation represents the smallest measurement uncertainty attainable by the laboratory when performing a more or less routine calibration of a nearly ideal device under nearly ideal conditions. It is typically expressed at a confidence level of 95 % using a coverage factor  $k$  (usually equal to 2). The actual measurement uncertainty associated with a specific calibration performed by the laboratory will typically be larger than the CMC for the same calibration since capability and performance of the device being calibrated and the conditions related to the calibration may reasonably be expected to deviate from ideal to some degree.
2. The laboratories range of calibration capability for all disciplines for which they are accredited is the interval from the smallest calibrated standard to the largest calibrated standard used in performing the calibration. The low end of this range must be an attainable value for which the laboratory has or has access to the standard referenced. Verification of an indicated value of zero in the absence of a standard is common practice in the procedure for many calibrations but by its definition it does not constitute calibration of zero capacity.
3. The presence of a superscript F means that the laboratory performs calibration of the indicated parameter at its fixed location. Example: Outside Micrometer<sup>F</sup> would mean that the laboratory performs this calibration at its fixed location.

